

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination MATSUI ET AL.	
			Examiner Ethan Whisenant, Ph.D.	Art Unit 1634	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0161801	08-2004	Ban et al.	435/007.1
*	B	US-2005/0064426	03-2005	Zou et al.	435/006
*	C	US-7,011,947	03-2006	Golub et al.	435/6
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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